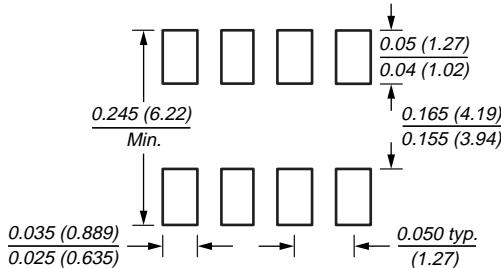
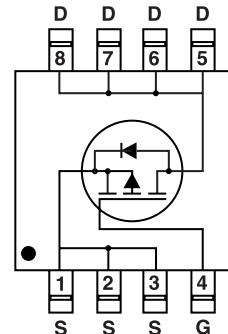
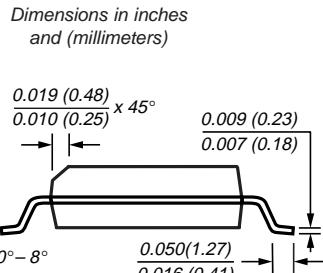
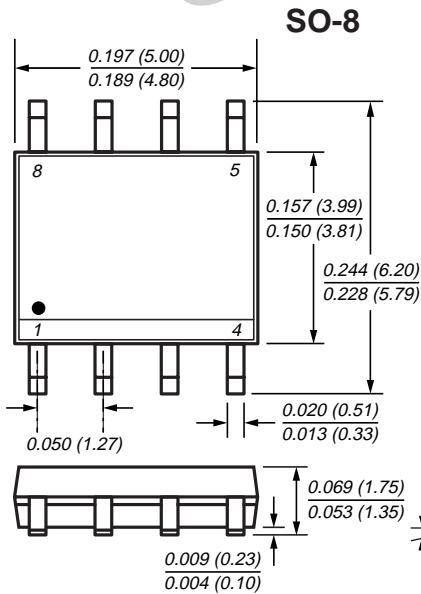




**TRENCH  
GENFET®**

## P-Channel Enhancement-Mode MOSFET

V<sub>DS</sub> –30V R<sub>DS(ON)</sub> 20mΩ I<sub>D</sub> –8.0A



**Mounting Pad Layout**

### Mechanical Data

**Case:** SO-8 molded plastic body

**Terminals:** Leads solderable per MIL-STD-750, Method 2026

**High temperature soldering guaranteed:**  
250°C/10 seconds at terminals

**Mounting Position:** Any    **Weight:** 0.5g

### Features

- Advanced Trench Process Technology
- High Density Cell Design for Ultra Low On-Resistance
- Specially Designed for Low Voltage DC/DC Converters
- Fast Switching for High Efficiency

### Maximum Ratings and Thermal Characteristics (T<sub>A</sub> = 25°C unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	V <sub>DS</sub>	-30	V
Gate-Source Voltage	V <sub>GS</sub>	±20	
Continuous Drain Current	I <sub>D</sub>	-8.0	A
Pulsed Drain Current	I <sub>DM</sub>	-50	
Maximum Power Dissipation	P <sub>D</sub>	2.5 1.6	W
Operating Junction and Storage Temperature Range	T <sub>J</sub> , T <sub>stg</sub>	-55 to 150	°C
Maximum Junction-to-Ambient Thermal Resistance <sup>(1)</sup>	R <sub>θJA</sub>	50	°C/W

**Note:** (1) Surface Mounted on FR4 Board, t ≤ 10 sec.

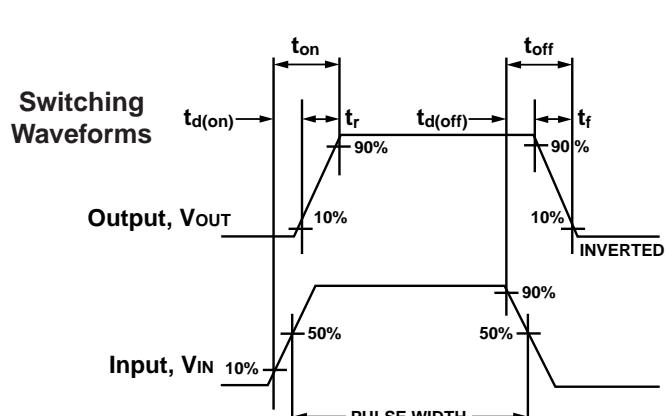
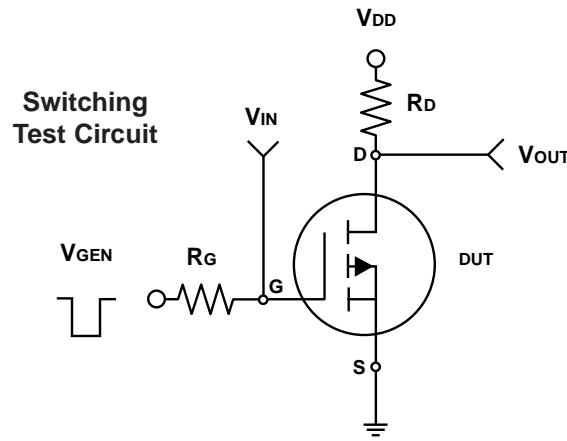
# P-Channel Enhancement-Mode MOSFET

## Electrical Characteristics ( $T_J = 25^\circ\text{C}$ unless otherwise noted)

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
<b>Static</b>						
Gate Threshold Voltage	$V_{GS(\text{th})}$	$V_{DS} = V_{GS}$ , $I_D = -250\mu\text{A}$	-1.0	-	-3.0	V
Gate-Body Leakage	$I_{GSS}$	$V_{DS} = 0\text{V}$ , $V_{GS} = \pm 20\text{V}$	-	-	$\pm 100$	nA
Zero Gate Voltage Drain Current	$I_{DSS}$	$V_{DS} = -30\text{V}$ , $V_{GS} = 0\text{V}$	-	-	-1.0	$\mu\text{A}$
On-State Drain Current <sup>(1)</sup>	$I_{D(\text{on})}$	$V_{DS} \geq -5\text{V}$ , $V_{GS} = -10\text{V}$	-40	-	-	A
Drain-Source Breakdown Voltage	$BVDSS$	$V_{GS} = 0\text{V}$ , $I_D = -250\mu\text{A}$	-30	-	-	V
Drain-Source On-State Resistance <sup>(1)</sup>	$R_{DS(\text{on})}$	$V_{GS} = -10\text{V}$ , $I_D = -8.0\text{A}$	-	15.3	20	$\text{m}\Omega$
		$V_{GS} = -4.5\text{V}$ , $I_D = -5.0\text{A}$	-	25.3	35	
Forward Transconductance <sup>(1)</sup>	$g_{fs}$	$V_{DS} = -15\text{V}$ , $I_D = -8.0\text{A}$	-	22	-	S
<b>Dynamic</b>						
Total Gate Charge	$Q_g$	$V_{DS} = -15\text{V}$ , $V_{GS} = -10\text{V}$ $I_D = -4.6\text{A}$	-	54	60	nC
Gate-Source Charge	$Q_{gs}$		-	8.5	-	
Gate-Drain Charge	$Q_{gd}$		-	10.3	-	
Turn-On Delay Time	$t_{d(\text{on})}$	$V_{DD} = -15\text{V}$ , $R_L = 15\Omega$ $I_D \approx -1\text{A}$ , $V_{GEN} = -10\text{V}$ $R_G = 6\Omega$	-	24	30	ns
Rise Time	$t_r$		-	12	30	
Turn-Off Delay Time	$t_{d(\text{off})}$		-	78	120	
Fall Time	$t_f$		-	37	80	
Input Capacitance	$C_{iss}$	$V_{GS} = 0\text{V}$ $V_{DS} = -15\text{V}$ $f = 1.0\text{MHz}$	-	2520	-	pF
Output Capacitance	$C_{oss}$		-	490	-	
Reverse Transfer Capacitance	$C_{rss}$		-	335	-	
<b>Source-Drain Diode</b>						
Maximum Diode Forward Current	$I_s$		-	-	-2.1	A
Diode Forward Voltage	$V_{SD}$	$I_s = -2.1\text{A}$ , $V_{GS} = 0\text{V}$	-	-0.75	-1.2	V

**Note:**

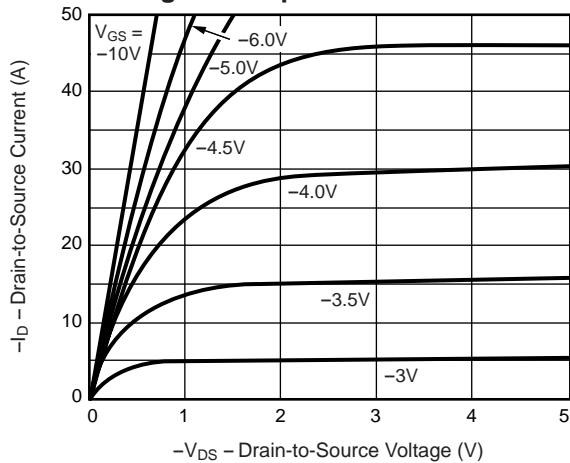
(1) Pulse test; pulse width  $\leq 300\ \mu\text{s}$ ,  
duty cycle  $\leq 2\%$



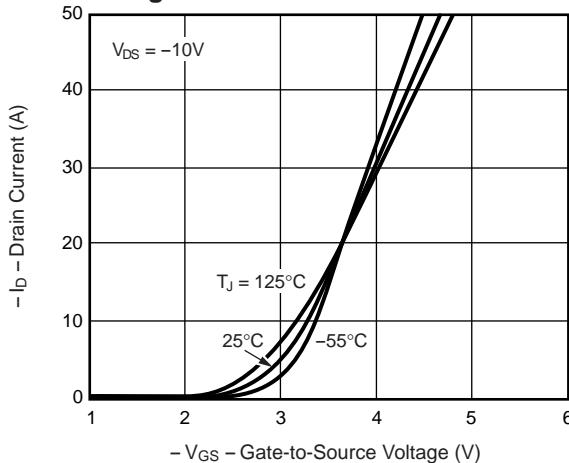
## P-Channel Enhancement-Mode MOSFET

### Ratings and Characteristic Curves (TA = 25°C unless otherwise noted)

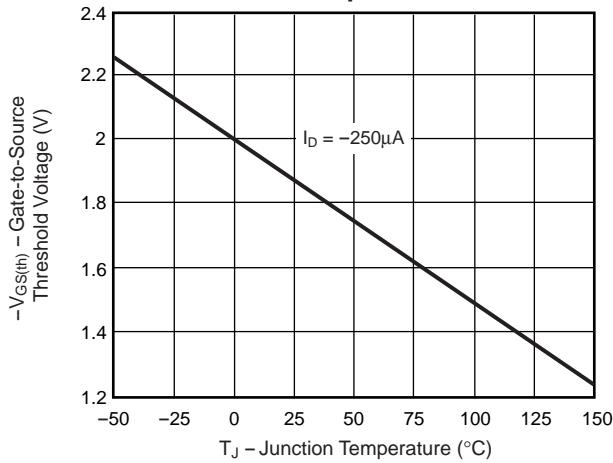
**Fig. 1 – Output Characteristics**



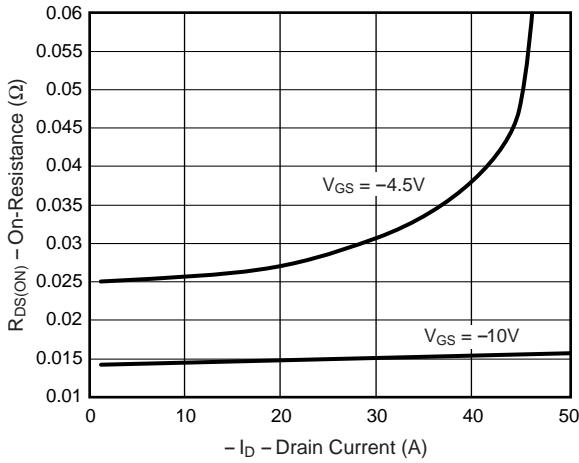
**Fig. 2 – Transfer Characteristics**



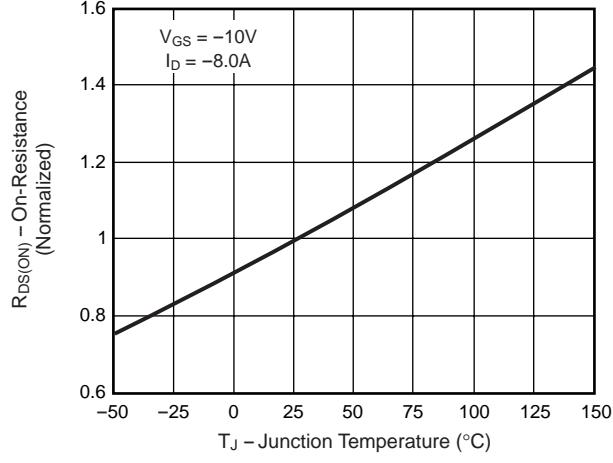
**Fig. 3 – Threshold Voltage vs. Temperature**



**Fig. 4 – On-Resistance vs. Drain Current**



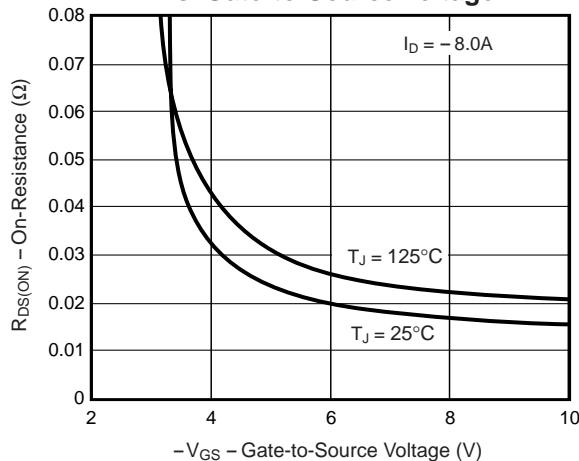
**Fig. 5 – On-Resistance vs. Junction Temperature**



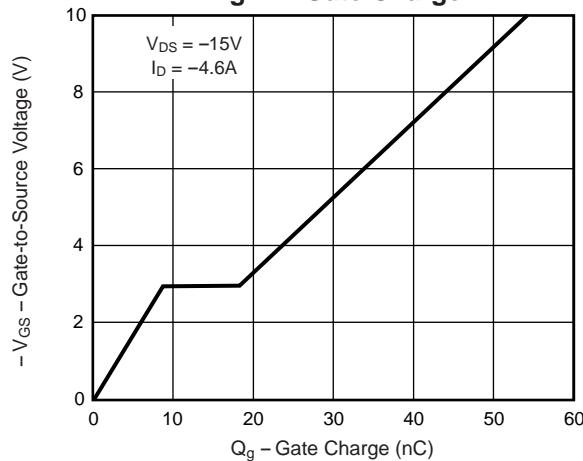
# P-Channel Enhancement-Mode MOSFET

## Ratings and Characteristic Curves ( $T_A = 25^\circ\text{C}$ unless otherwise noted)

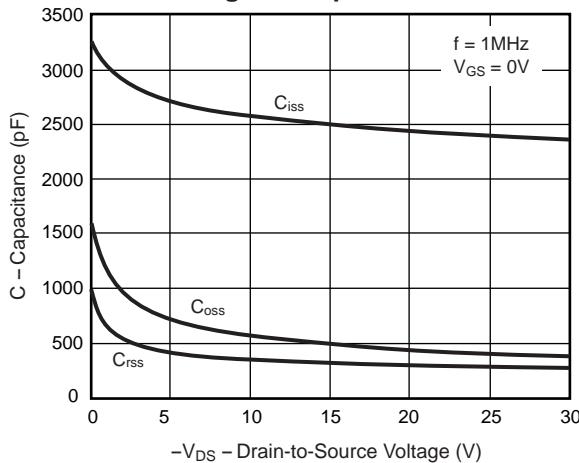
**Fig. 6 – On-Resistance vs. Gate-to-Source Voltage**



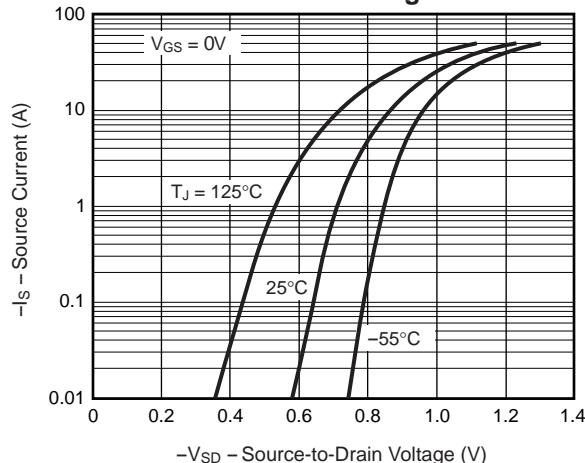
**Fig. 7 – Gate Charge**



**Fig. 8 – Capacitance**



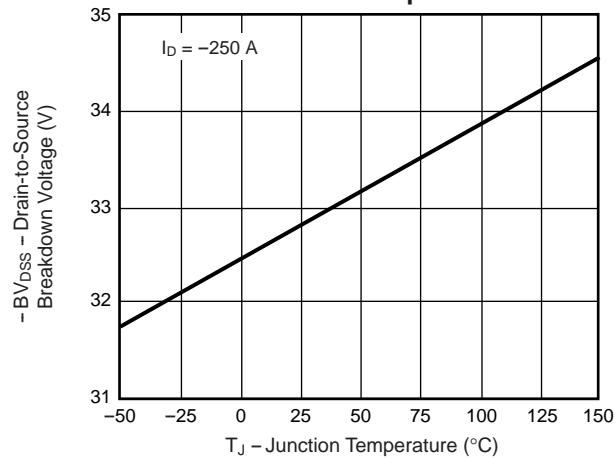
**Fig. 9 – Source-Drain Diode Forward Voltage**



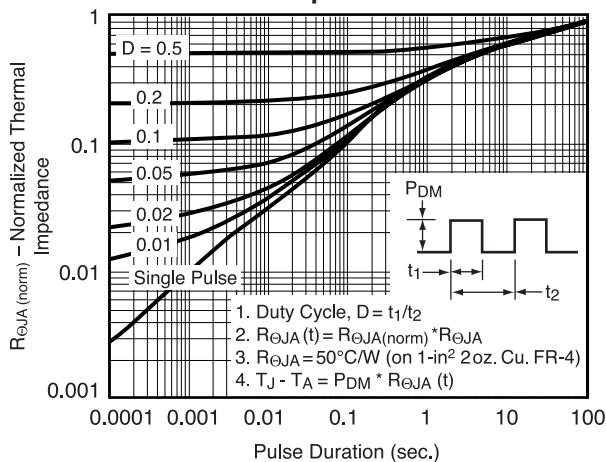
## P-Channel Enhancement-Mode MOSFET

### Ratings and Characteristic Curves (TA = 25°C unless otherwise noted)

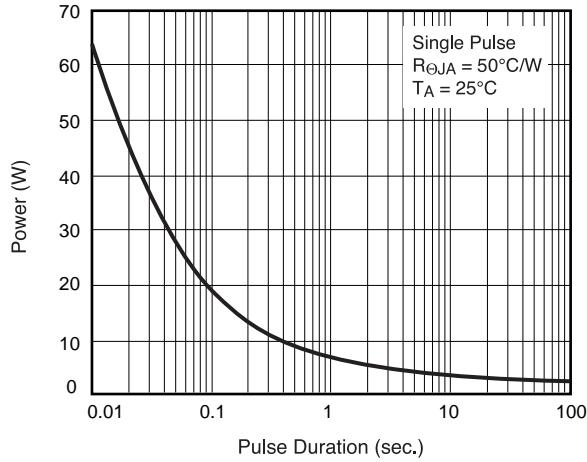
**Fig. 10 – Breakdown Voltage vs. Junction Temperature**



**Fig. 11 – Transient Thermal Impedance**



**Fig. 12 – Power vs. Pulse Duration**



**Fig. 13 – Maximum Safe Operating Area**

